


<b>Search Notes</b>  	<b>Application/Control No.</b>  10540584	<b>Applicant(s)/Patent Under Reexamination</b>  AKADA ET AL.
	<b>Examiner</b>  Phu K Nguyen	<b>Art Unit</b>  2628

SEARCHED			
Class	Subclass	Date	Examiner
update search		3/15/08	pn

SEARCH NOTES			
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INTERFERENCE SEARCH			
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